

Notice of References Cited	Application/Control No. 10/727,470	Applicant(s)/Patent Under Reexamination KWAK, NOH YEAL	
	Examiner Victor V Yevsikov	Art Unit 2825	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,087,222	07-2000	Jung Lin et al.	438/259
	B	US-6,124,608	09-2000	Liu et al.	257/315
	C	US-2003/0094636 A1	05-2003	Maeda, Shigenobu	257/288
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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